

<b>Notice of References Cited</b>	Application/Control No. 10/577,267	Applicant(s)/Patent Under Reexamination HAWKINS ET AL.	
	Examiner PINKAL R. CHOKSHI	Art Unit 2425	Page 1 of 3

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-8,028,315	09-2011	Barber, David	725/47
*	B	US-2011/0162010	06-2011	Ellis et al.	725/40
*	C	US-2010/0223642	09-2010	Knudson et al.	725/41
*	D	US-2010/0154000	06-2010	Macrae et al.	725/41
*	E	US-7,661,119	02-2010	Arsenault et al.	725/48
*	F	US-7,620,965	11-2009	Miyazaki et al.	725/42
*	G	US-2009/0241144	09-2009	LaJoie et al.	725/40
*	H	US-7,530,087	05-2009	Akhavan et al.	725/43
*	I	US-2009/0070815	03-2009	Barrett et al.	725/43
*	J	US-2008/0307460	12-2008	Knudson et al.	725/50
*	K	US-7,434,247	10-2008	Dudkiewicz et al.	725/46
*	L	US-2008/0178221	07-2008	Schein et al.	725/42
*	M	US-7,389,525	06-2008	Sullivan, Gary E.	725/50

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

**Notice of References Cited**

Application/Control No.

10/577,267

Applicant(s)/Patent Under  
Reexamination  
HAWKINS ET AL.

Examiner

PINKAL R. CHOKSHI

Art Unit

2425

Page 2 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,212,729	05-2007	Nakajima et al.	386/291
*	B	US-2005/0229233	10-2005	Zimmerman et al.	725/135
*	C	US-2005/0198668	09-2005	Yuen et al.	725/047
*	D	US-2005/0193415	09-2005	Ikeda, Yuuichirou	725/049
*	E	US-6,934,965	08-2005	Gordon et al.	725/54
*	F	US-2005/0071887	03-2005	Yoshida, Osamu	725/135
*	G	US-6,701,526	03-2004	Trovato, Karen I.	725/39
*	H	US-2004/0003406	01-2004	Billmaier, James A.	725/60
*	I	US-2002/0188944	12-2002	Noble, Taber B.	725/39
*	J	US-6,486,920	11-2002	Arai et al.	348/563
*	K	US-2002/0104081	08-2002	Candelore et al.	725/9
*	L	US-6,418,556	07-2002	Bennington et al.	725/40
*	M	US-6,400,406	06-2002	Kim, Jin-hwi	348/460

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

**Notice of References Cited**

Application/Control No.

10/577,267

Applicant(s)/Patent Under  
Reexamination  
HAWKINS ET AL.

Examiner

PINKAL R. CHOKSHI

Art Unit

2425

Page 3 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,243,145	06-2001	Schlarb et al.	725/39
*	B	US-6,208,799	03-2001	Marsh et al.	386/292
*	C	US-5,841,433	11-1998	Chaney, John William	725/50
*	D	US-5,589,892	12-1996	Knee et al.	725/43
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.